MTP3055VL



SEMICONDUCTOR

MTP3055VL N-Channel Logic Level Enhancement Mode Field Effect Transistor

General Description

Features

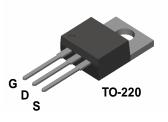
This N-Channel Logic Level MOSFET has been designed specifically for low voltage, high speed switching applications i.e. power supplies and power motor controls.

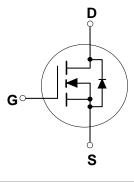
This MOSFET features faster switching and lower gate charge than other MOSFETs with comparable $R_{_{\text{DS(ON)}}}$ specifications.

The result is a MOSFET that is easy and safer to drive (even at very high frequencies).

- 12 A, 60 V. $\mathrm{R}_{\mathrm{DS(ON)}}$ = 0.18 Ω @ V_{GS} = 5 V

- Critical DC electrical parameters specified at elevated temperature.
- Low drive requirements allowing operation directly from logic drivers. Vgs(th) < 2 V.
- Rugged internal source-drain diode can eliminate the need for an external Zener diode transient suppressor.
- 175°C maximum junction temperature rating.





Absolute Maximum Ratings T_c = 25°C unless otherwise noted

Symbol	Parameter		Ratings	Units
V _{DSS}	Drain-Source Voltage		60	V
V _{GSS}	Gate-Source Voltage		<u>+</u> 15	V
I _D	Drain Current - Continuous		12	А
	- Pulsed		42	
P _D	Power Dissipation @ T _C = 25°C		48	W
	Derate above 25°C		0.32	W/∘C
T _J , T _{STG}	Operating and Storage Junction Temperature Range		-65 to +175	۰C
[hermal	Characteristics			
R _{AJC}	Thermal Resistance, Junction-to-	Case	3.13	∘C/W
R _{AJA}	Thermal Resistance, Junction-to- Ambient (Note 1)		62.5	∘C/W
	Outlines and Orderin	a Information	•	

	MTP3055VL	MTP3055VL	Rails/Tubes	45 units
* Die and manufacturing source subject to change without prior notification.				

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units	
DRAIN-S	OURCE AVALANCHE RATI	NGS (Note 2)				r	
WDSS	Single Pulse Drain-Source Avalanche Energy	$V_{DD} = 25 \text{ V}, I_D = 12 \text{ A}$			72	mJ	
I _{AR}	Maximum Drain-Source Avalanche	e Current			12	A	
)ff Chara	cteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0~V,~I_{D}=250~\mu A$	60			V	
ΔBV_{DSS} ΔT_J	Breakdown Voltage Temperature Coefficient	I_D = 250 µA, Referenced to 25°C		55		mV/°C	
I _{DSS}	Zero Gate Voltage Drain Current	$V_{\text{DS}} = 60 \ \text{V}, \ V_{\text{GS}} = 0 \ \text{V}$			10	μΑ	
		$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 150^{\circ}\text{C}$			100		
IGSSF	Gate-Body Leakage Current, Forward	$V_{GS} = 15 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA	
GSSR	Gate-Body Leakage Current, Reverse	$V_{GS} = -15 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA	
)n Chara	cteristics (Note 2)						
V _{GS(th)}	Gate Threshold Voltage	$V_{\text{DS}} = V_{\text{GS}}, \ I_{\text{D}} = 250 \ \mu\text{A}$	1	1.6	2	V	
$\Delta V_{GS(th)} = \Delta T_{J}$	Gate Threshold Voltage Temperature Coefficient	$I_D = 250 \ \mu A$, Referenced to $25^{\circ}C$		-4		mV/°C	
R _{DS(on)}	Static Drain-Source On-Resistance	$V_{GS} = 5 V, I_D = 6 A,$		0.100	0.180	Ω	
/ _{DS(on)}	Drain-Source On-Voltage On-Resistance	$V_{GS} = 5 V, I_{D} = 12 A$			2.6	V	
J FS	Forward Transconductance	$V_{DS} = 8 V, I_{D} = 6 A$	5	8.7		S	
vnamic	Characteristics						
2 _{iss}	Input Capacitance	$V_{DS} = 25 V, V_{GS} = 0 V,$		345	570	pF	
Coss	Output Capacitance	f = 1.0 MHz		110	160	pF	
2 _{rss}	Reverse Transfer Capacitance			30	40	pF	
witching	Characteristics (Note 2)						
d(on)	Turn-On Delay Time	V _{DD} = 30 V, I _D = 12 A,			20	ns	
r	Turn-On Rise Time	V_{GS} = 5 V, R_{GEN} = 9.1 Ω			190	ns	
d(off)	Turn-Off Delay Time				30	ns	
f	Turn-Off Fall Time				90	ns	
ג	Total Gate Charge	V _{DS} = 48 V,		7.8	10	nC	
ر پ _{gs}	Gate-Source Charge	$I_D = 12 \text{ A}, V_{GS} = 5 \text{ V}$		1.7		nC	
$\hat{\boldsymbol{\lambda}}^{\mathrm{ad}}$	Gate-Drain Charge			3.2		nC	
				•			
	urce Diode Characteristics Maximum Continuous Drain-Source			<u> </u>	12	<u>م</u>	
S	Maximum Continuous Drain-Source Di			-	12	A	
sm / _{SD}	Drain-Source Diode Forward	$ \begin{array}{ll} \text{ode Forward Current} & (\text{Note 2}) \\ \hline V_{\text{GS}} = 0 \ V, \ I_{\text{S}} = 12 \ \text{A} & (\text{Note 2}) \\ \end{array} $			42 1.3	A V	
rr	Voltage Drain-Source Reverse Recovery Time	I _F =12 A, di/dt = 100A/µs		55		nS	

MTP3055VL

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